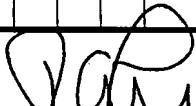
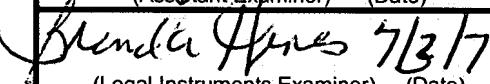


Issue Classification			Application/Control No.		Applicant(s)/Patent under Reexamination	
			10/539,342		MIHAN ET AL.	
			Examiner		Art Unit	
			Rip A. Lee		1713	

ORIGINAL			CROSS REFERENCE(S)				
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
556	63	556	58	57			
INTERNATIONAL CLASSIFICATION			526	172	161	160	170
C	0	7	F	11/00	260	665R	
C	0	7	F	1/02			
			/				
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			/				
 (Assistant Examiner) <i>July 02, 2007</i>  (Primary Examiner) <i>7/2/07</i>			 DAVID W. WU ADVISORY PATENT EXAMINER TECHNOLOGY CENTER 1700 (Primary Examiner) <i>7/2/07</i>		Total Claims Allowed: 2 O.G. Print Claim(s) <i>1</i> O.G. Print Fig. <i>---</i>		
 (Legal Instruments Examiner) <i>7/3/07</i>							

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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